Applicant(s)/Patent Under Application/Control No. Reexamination 10/662,426 LEE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 1746 Saeed T. Chaudhry **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	· Name	Classification
*	Α	US-RE36,767	07-2000	Itzkowitz, Herman	15/77
*	В	US-5,375,291	12-1994	Tateyama et al.	15/302
*	С	US-5,846,335	12-1998	Maekawa et al.	134/6
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-	·		
	J	US-			
	К	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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